

Application/Control No. 10/760,668	Applicant(s)/Patent under Reexamination CONCHA ET AL.	
Examiner	Art Unit	
Chen-Wen Jiang	3744	

				ISSUE	CL	AS	SIF	ICAT	ION			
	INTERNATIONAL CLASSIFICATION											
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(Legal In	(Legal Instruments Examiner) (Date)				PRIMARY EXAMINER (Primary Examiner) (Date) Print Claim(s)							Print Fig.

	Claims renumbered in the same order as presented by applicant							□СРА			☐ T.D.			☐ R.1.47					
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151	,		181
2	2			32			62			92			122			152			182
	3			33			63			93			123			153			183
	4			34			64			94			124			154			184
6	5			35			65			95			125			155			185
3	6			36			66			96			126			156			186
4	7			37			67			97			127			157			187
5	8			38			68			98			128			158			188
7	9			39			69			99			129			159			189
8	10			40			70			100			130			160			190
	11]		41			71			101			131			161			191
	12			42			72			102			132			162			192
9	13			43			73			103			133			163			193
10	14			44			74]		104			134			164			194
11	15			45			75			105			135			165			195
	16			46			76]		106			136			166			196
	17]		47			77			107			137			167			197
12	18			48]		78]		108			138			168			198
13	19]		49	}		79			109			139			169			199
14	20			50			80	}		110			140			170			200
	21	•		51]		81			111			141			171			201
	22]		52			82			112			142			172			202
	23	}		53]		83]		113			143			173			203
	24			54			84			114			144			174			204
	25] .		55			85			115			145			175			205
	26	1		56			86			116			146			176			206
	27]		57	1		87	1		117			147			177			207
	28	1		58	1		88	1		118			148			178			208
	29	1		59			89	1		119			149			179			209
	30			60	L		90			120			150			180			210